Studies of Molybdenum Surface Modification for Growth of Adherent CVD Diamond Film

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Surfaces with very poor mechanical and frictional properties can be improved, or even, acquire new properties similar to diamond if good adherent CVD diamond film is obtained on it. In this work, nitrogen ions were sub-implanted on pure molybdenum as a means to enhance CVD diamond film adherence. Deposition time from 2 up to 60 h were used for deposition of 10 to 400 µm thick CVD diamond films with very good adherence on sub-implanted molybdenum substrate. Characterizations were carried out by XPS, X-ray diffraction and nano indentation on prepared surfaces prior to diamond growth and after the onset nucleation. The ionic sub-implantation with nitrogen possibly assists in adhesion, with the creation of a thin layer of nitrates and complexes.

Keywords: CVD Diamond, surface modification, ion sub-implantation, thin film

1. Introduction

The interest in diamond coating technology specifically on pre-shaped parts and synthesis of freestanding shapes of diamond has increased worldwide especially because of vast and exotic applications1-5. CVD diamond is far beyond the traditional technology, and it has been deposited on a variety of substrates, including metals, refractory metals, semiconductors and ceramics. Applications are widespread on several areas, and new applications are continuously proposed, even for the applications categorized as advantageous substitution of traditional products. The novelty products are the ones only possible due to the advent of CVD diamond technology. CVD diamond coated cutting tools, heat sinks, abrading devices, special optical coatings, substrates for multichip modules technology (MCM), electron field emitters and electrodes for electrochemical uses, is only a small list of interesting area of exploration. In the development of these application areas, there is much interest in understanding the mechanism and the role of the interface between the film and substrate concerning the adhesion process and, a lot of effort has been spent to understand the effect of intrinsic and extrinsic stresses involving diamond and DLC films on different kinds of substrate materials6-7. More specifically, adherence between CVD diamond film and metallic substrate represent, for many research groups, the challenge to overcome. The main problems are related to difference in thermal expansion coefficient and adherence between the substrate and the diamond film. Using different kind of surface preparation and intermediate interface, good adherence between CVD diamond and WC-Co, Si₃N₄, SiC, and others8,9 have been obtained with relatively success in order to improve the lifetime of different kind of tools. Stainless steel and tool steel have been tried as a permanent substrate for CVD diamond growth, where, at the first time, the sub-implantation was mentioned9 as a surface preparation technique. Nitride films are known as a diffusion barriers in microelectronics devices and as well as superconductors10. Synthesis and analysis of molybdenum nitrides formed during ion implantation were investigated by some authors in order to improve molybdenum tribological properties and to understand the complexes formed11,12.
In this work, concerning carbon diffusion during growth, the improvement of the adherence of the diamond film on molybdenum has been studied as a function of the surface modification by nitrogen ion implantation and deposition time in order to get thick diamond films. The adherence between them depends on how properly the interface is prepared. In this case very thin interface between diamond and metal was studied in order to avoid carbon diffusion onto the bulk of the substrate at diamond growth conditions, and also, for improving the chemical bond between the film and the substrate.

2. Experiment

Molybdenum rods of 1.6 mm diameter and 20 mm long were polished using diamond powder of 0.25 µm grit and slurried in n-hexane ultrasonic bath (1 g/20 ml) during 60 min and annealed in H₂ prior to DC discharge nitrogen ion sub-implantation.

The experimental apparatus for nitrogen sub-implantation consists of a conventional DC discharge with special geometry of the electrodes. A conventional hot filament reactor with convenient substrate holder, as it is shown in Fig. 1, was used for diamond film growth.

Nitrogen and hydrogen mixtures were used in the DC discharge to produce a thin-nitrated layer by ion sub-implantation. The best set of parameters was found according to the best adherence after diamond deposition. Diamond deposition was carried out with conventional mixtures of 2% vol.% of CH₄ in H₂. The total gas flow rate was fixed at 100 sccm and the pressure inside the reactor was maintained at 50 torr. The 850 °C substrate temperature was measured by a thermocouple, and from 2 up to 60 h deposition time was used for deposition of 10 to 400 µm thick CVD diamond films, without delaminating.

Small angle X-ray Diffraction was performed in the nitrated molybdenum and nitrated molybdenum after 10 min of diamond nucleation. The XPS analysis was made on the molybdenum surface for all sets of samples.

In order to get good nano-indentation tests, only the 10 µm thick films grown in pure and nitrated molybdenum were used.

3. Results and Discussions

Experiments have shown that higher temperature helped to improve the film adhesion, but it was not sufficient to avoid the film peeling off from the substrate after growing. An optimization of the sub-implantation parameters have been made in order to keep the integrity of the molybdenum structure during all sub-implantation process at temperatures ranging from 500 to 600 °C and, to increase the film adhesion. We found that good film quality and high nucleation density are reached at temperatures as high as 850 °C, for films grown up to 400 µm thick during 60 h nitrated molybdenum substrate. In this work the best condition for nitrogen ion implantation was reached using nitrogen 20% vol. in hydrogen and at 600 V DC discharge.

Small angle X-ray Diffraction was performed in order to understand surface modification and how the most probable mechanism interferes on diamond adherence to the molybdenum surface when nitrogen ion-sub-implantation occurs. The results of pure molybdenum, nitrated molybdenum and nitrated molybdenum after 10 min of diamond nucleation are shown in Fig. 2. The apparent molybdenum nitride peaks give us the evidence of the surface modification for the nitrated molybdenum. The spectrum of a substrate after submitted to 10 min diamond nucleation shows the evident mixture of the molybdenum nitrides and carbides. However, the X-ray analysis is not sensitive to other complexes formed during the sub-implantation.

Our first attempt to observe the existence of such complexes was by using XPS analysis. Fig. 3a shows the analysis from nitrated molybdenum surface prepared for diamond growth. The binding energy around 227 and 232 eV are the evidence of nitrides and oxides formation. In Fig. 3b the peaks around 396 and 412 eV correspond to surface compounds with nitrogen and oxygen, respectively. Again, one
Figure 2. Small angle X-ray Diffraction for: a) pure molybdenum (continuous line) and nitrated molybdenum (dashed line); b) nitrated molybdenum surface after 10 min diamond onset nucleation.

Figure 3. XPS analysis characterization for nitrated molybdenum: a) molybdenum nitrides and oxides; b) complexes with nitrogen and oxygen.

Figure 4. XPS analysis characterization for nitrated molybdenum after 10 min diamond growth: a) shifted and asymmetric binding energy peak for the carbon; b) shifted and asymmetric binding energy peaks for molybdenum complexes.
can speculate that even complexes can be formed on molybdenum surface from ion bombardment and contribute to form a barrier against carbon diffusion during diamond growth process. In order to see the influence of this barrier, XPS analysis were carried out on substrate-cleaned surface after 10 min diamond nucleation. It is observed again the evidence of complex compounds now involving carbon atoms, characterized by the shifted and asymmetric binding energy peaks centered at 393 and 411 eV, as shown in Fig. 4a. In Fig. 4b the C1s peak, binding energy centered at 282 eV, depicts a strong asymmetry that corroborates the idea of a complex compound formation.

Figure 5 shows the change of C and N% content on nitrated molybdenum surface and C% content on nitrite molybdenum bulk as a function of the growth time. We can see that the N% content is almost independent of the growth time, the C content increase on nitrite molybdenum surface with the growth time but in the molybdenum bulk, the C% content remains constant as long as for 20 h of growth, indicating that the complex barrier help to avoid the diffusion of the carbon to the bulk of the substrate.

It is observed from Fig. 6a, that the bulk hardness is higher for samples with nitrated surface prior to diamond growth conditions, and it decrease when submitted to 10 min diamond growth conditions, but it is still high and keep the same behavior. The hardness is higher in the surface and decrease up to a depth of 150 nm. Substrates without nitrogen sub-implantation and submitted to 10 min diamond growth condition has lower hardness and it doesn’t exhibit hardness variation as function of the depth. Also, the stiffness (Fig. 6b) has been analyzed for the same samples. Samples with nitrogen sub-implantation exhibit dependence with the depth, while only a small variation of the stiffness was observed for samples without nitrogen sub-implantation. These results confirm that a barrier for carbon diffusion could be formed when nitrogen sub-implantation is used, indicating a surface modification.

Using this results, diamond thin and thick film have been obtained on molybdenum submitted to nitrogen sub-implantation with very good adherence even at growth temperature as low as 700 °C, and different kind of devices have been developed. Examples of these devices are the diamond burr used in very high rotation, as higher as 400.000 rpm, and in high-energy ultrasound application. The lifetime of these devices is over than 30 times larger than conventional one. Figure 7 shows some examples of mentioned devices.
4. Conclusion

Ions sub-implantation on molybdenum has been presented as a good way to obtain good adherence with CVD diamond. Nano indentation, small angle X-ray diffraction and XPS analysis show an evidence of surface modification by the formation of nitrogen and carbon complexes. This surface modification was efficient in inhibiting carbon diffusion during the diamond growth process keeping the mechanical properties of the substrate. Also, these complexes contribute to improve the adherence of diamond to the modified molybdenum surface. Examples, as diamond Burr, of very adherent diamond thick film on modified molybdenum surface confirm the success of these studies.

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